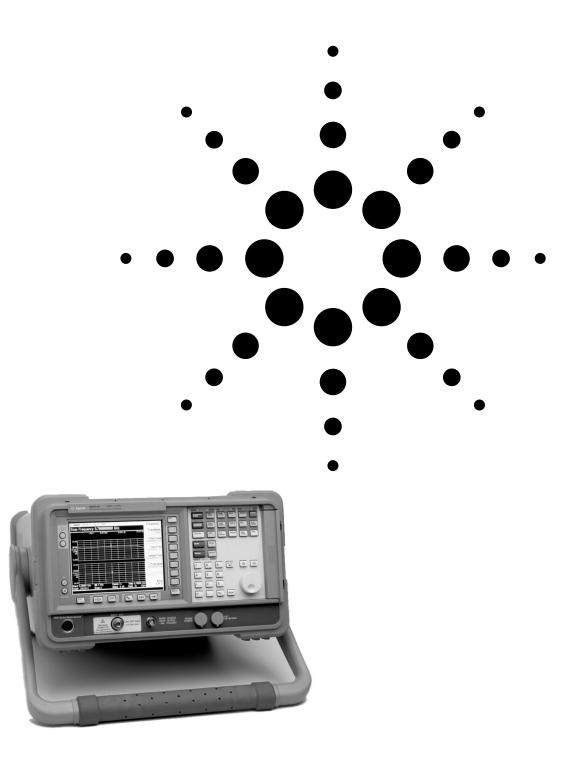
Agilent N8972A, N8973A, N8974A, N8975A NFA Series Noise Figure Analyzers

Data Sheet



Specifications

Specifications are only valid for the stated operating frequency, and apply over 0° C to $+55^{\circ}$ C unless otherwise noted. The analyzer will meet its specifications after 2 hours of storage within the operating temperature range, 60 minutes after the analyzer is turned on, with Alignment running. A user calibration is required before corrected measurements can be made.

Frequency

Frequency range¹

 N8972A
 10 MHz to 1.5 GHz

 N8973A
 10 MHz to 3.0 GHz

 N8974A
 10 MHz to 6.7 GHz

 N8975A
 10 MHz to 26.5 GHz

Measurement bandwidth (nominal)

N8972A 4 MHz

N8973A, N8974A, N8975A 4 MHz, 2 MHz, 1 MHz, 400 kHz, 200 kHz, 100 kHz

Frequency reference

Tuning Accuracy ⁵ (Start, Stop, Center, Marker)

4MHz measurement Bandwidth (default on all models of Noise Figure analyzer)

Frequency Error

10 MHz - 3.0 GHz $\pm < \text{Reference error} + 100 \text{ kHz}$ 3.0 GHz - 26.5 GHz $\pm < \text{Reference error} + 400 \text{ kHz}$

<4 MHz- Measurement Bandwidth (functionality not present in N8972A)

Frequency Error

10MHz - 3.0 GHz < ± Reference error + 20 kHz

3.0GHz - 26.5 GHz < ± Reference error + 20% of measurement bandwidth

^{1.} The N8974A and N8975A models have a mechanical switch fitted. This switch allows the analyzers to change between the 10 MHz to 3.0GHz and the 3.0 GHz to 6.7 GHz frequency range on the N8974A. On the N8975A, the switch allows the change between the 10 MHz to 3.0 GHz and the 3.0GHz to 26.5 GHz frequency range. If the current measurement frequency range crosses the 3.0GHz point, the switch will operate. The mechanical switch has a limited number of cycles over which it is reliable. To maximize the reliable life of the switch, switching over the 3.0GHz frequency point should be kept to a minimum.

^{2.} Temperature stability on the standard frequency reference is achieved 60 minutes after the analyzer is turned on.

^{3.} Option 1D5 recommended for applications requiring high frequency stability.

^{4.} Parts Per Million (10⁻⁶).

^{5.} Tuning accuracy is dependent on measurement bandwidth.

Noise figure and gain

Performance is dependent on the $ENR^1\,$ of the noise source used:

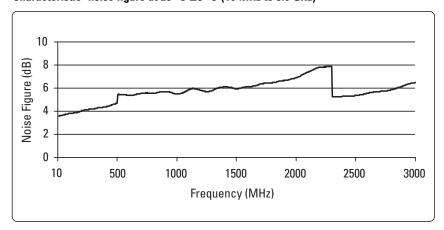
N8972A		Noise source ENR				
		4-7 dB	12-17 dB	20-22 dB		
Noise figure	Measurement range	0 to 20 dB	0 to 30 dB	0 to 35 dB		
	Instrument uncertainty	± < 0.1 dB	\pm < 0.1 dB	$\pm < 0.15 dB$		
Gain ²	Measurement range	-20 to +40 dB				
	Instrument uncertainty	$\pm < 0.17 \text{ dB}$				
		T				
N8973A, N89	74A and N8975A	Noise source ENR				
(10 MHz to 3.0	GHz)	4-7 dB	12-17 dB	20-22 dB		
Noise figure	Measurement range	0 to 20 dB	0 to 30 dB	0 to 35 dB		
_	Instrument uncertainty	± < 0.05 dB	± <0.05 dB	\pm < 0.1 dB		
Gain ²	Measurement range		-20 to +40 dB			
	Instrument uncertainty	rument uncertainty		± < 0.17 dB		
N8974A and	N8975A	Noise source ENR				
(>3.0 GHz)		4-7 dB	12-17 dB	20-22 dB		
Noise figure	Measurement range	0 to 20 dB	0 to 30 dB	0 to 35 dB		
-	Instrument uncertainty	± < 0.15 dB	± <0.15 dB	\pm < 0.2 dB		
Gain ²	Measurement range		-20 to +40 dB			
	Instrument uncertainty		$\pm < 0.17 dB$			

Instrument's noise figure

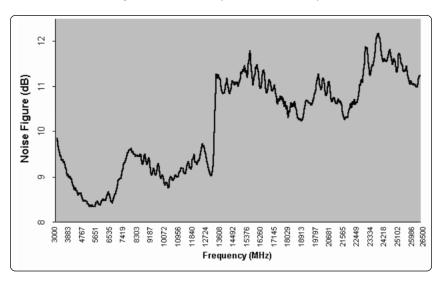
	10 MHz to	500 MHz to	2.3 GHz to	> 3 GHz to	13.2 GHz to
	< 500 MHz	< 2.3 GHz	3 GHz	13.2 GHz	26.5 GHz
	< 4.9 dB +	< 7.4 dB +	< 4.4 dB +	< 12 dB	< 16 dB
Noise figure	(0.0025 *	(0.00135 *	(0.0015 *		
	freq in MHz)	freq in MHz)	freq in MHz)		
Noise figure	< 4.4 dB +	< 5.9 dB +	< 2.9 dB +	< 10.5 dB	< 12.5 dB
over a limited	(0.0025 *	(0.00135 *	(0.0015 *		
temperature freq in MHz)		freq in MHz)	freq in MHz)		
range of					
23° C ± 3° C					

Excess Noise Ratio
 For measurement bandwidths below 4 MHz, and spacing between measurement points below 3 MHz, gain uncertainty may increase to a maximum of ± 0.7 dB.

Characteristic¹ noise figure at 23° C ±3° C (10 MHz to 3.0 GHz)



Characteristic¹ noise figure at 23° C ±3° C (3.0 GHz to 26.5 GHz)



Maximum external gain between noise source output and RF input²

> 65 dB

Averaging

Up to 999 measurement results

Jitter³

Jitter with no averaging4

5 dB Y-factor standard deviation < 0.1 dB

Characteristic values are met or bettered by 90% of instruments with 90% confidence.

^{1.} 2. 3.

Subject to maximum operating input power.

Specified for a 4 MHz measurement bandwidth. Jitter in noise figure is equivalent to jitter in Y-factor to within 10% for ENR>14dB and F<4dB. At minimum smoothing, jitter can limit accuracy; the small jitter at high smoothing does not.

For true Gaussian noise, jitter reduces with increased averaging typically by a factor of 1/√(number of averages)

RF input

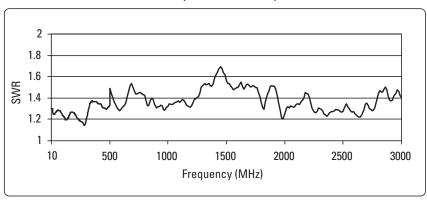
Connector

N8972A, N8973A N female, 50 Ω nominal N8974A, N8975A APC 3.5 (m), 50 Ω nominal (ESD sensitive)

SWR (50 Ω reference)

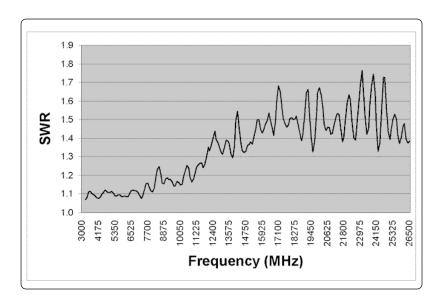
	10 MHz to	500 MHz to	1 GHz to	1.5 GHz to	3 GHz to	6.7 GHz to	20 GHz to
	500 MHz	1 GHz	1.5 GHz	3 GHz	6.7 GHz	20 GHz	26.5 GHz
SWR	< 1.6:1	< 1.8:1	< 1.9:1	< 1.8:1	< 1.3:1	< 2.1:1	< 2.4:1

Characteristic 1 SWR at 23° C $\pm 3^\circ$ C (10 MHz to 3.0 GHz)



^{1.} Characteristic values are met or bettered by 90% of instruments with 90% confidence.

Characteristic 1 SWR at 23° C $\pm 3^\circ$ C (3.0 Ghz to 26.5 Ghz)



Maximum operating input power² -10 dBm

Maximum protected input level

±20 Vdc; +15 dBm peak (or average) at RF

Characteristic values are met or bettered by 90% of instruments with 90% confidence.
This is the total wide-band noise power. Contributing factors are: Noise source ENR, external gain, noise figure and bandwidth (including DUT).

Measurement

Sweep

2 to 401, or fixed frequency Number of points Setting Start/Stop, Center/Span,

Frequency list of up to 401 points

Continuous or Single Sweep trigger

Measurement speed (nominal)

-	8 averages	64 averages			
N8972A (10 MHz to 1.5 GHz)	<100 ms/measurement	<80 ms/measurement			
N8973A (10 MHz to 3.0 GHz)	<50 ms/measurement	<42 ms/measurement			
	8 averages	64 averages			
N8974A (10 MHz to 3.0 GHz)	< 50 ms/measurement	<42 ms/measurement			
N8974A (3.0 GHz to 6.7 GHz)	< 70 ms/measurement	<50 ms/measurement			
N8975A (10 MHz to 3.0 GHz)	< 50 ms/measurement	<42 ms/measurement			
N8975A (3.0 GHz to 26.5 GHz)	< 70 ms/measurement	<50 ms/measurement			
Modes Amplifier					
Downconverter in DUT	With fixed or variable IF.				
	Instrument capable of controlling an external				
	LO via dedicated 'LO GPI	B' connector			
Upconverter in DUT	With fixed or variable IF.				
Instrument capable of controlling an exte					
	LO via dedicated 'LO GPI	2 000010.			
System downconverter	Allows the use of an external downconverting				
	mixer as part of the measurement system.				
	Instrument capable of controlling an external				
1	LO via dedicated 'LO GPIB' connector				
Loss compensation	Table of values vs. frequency for losses between noise source and DUT, and between DUT				
	and analyzer	iu netweeli no i			
SNS Series noise source	ENR tables automatic up	load Continuous unload			
Sing Selies Holse Source	LIVIT Lables automatic up	ioau. Goitiiiuous upioau			

of T_{cold}

Corrected Noise Figure and Gain measured on a 3dB pad with a repetitive sweep of 101 points from 600 MHz to 1.0 GHz with a 4 MHz measurement bandwidth. Corrected Noise Figure and Gain measured on a 3dB pad with a repetitive sweep of 101 points from 4.0 GHz to 6 GHz with a 4 MHz measurement bandwidth.

Display

Type 17cm color LCD panel

Output format Graphical, table of values, or meter mode

Display channels 2

Number of markers 4 per display channel

Limit lines Upper and lower for each of 2 channels

Display units

Noise figure (F dB), or as a ratio (F)
Gain Gain (G dB), or as a ratio (G)
Y-factor Y-factor (Y dB) or as a ratio (Y)

 $\begin{array}{ll} P_{hot} & & Relative \ power \ density \ in \ dB \ or \ as \ a \ ratio \\ P_{cold} & & Relative \ power \ density \ in \ dB \ or \ as \ a \ ratio \\ \end{array}$

Connectivity

GPIB IEEE-488 bus connector

LO GPIB IEEE-488 bus connector dedicated to local

oscillator control (SCPI or custom command set)

Serial RS-232, 9-pin D-Sub male

Printer 25-pin parallel D-Sub female, for connection

with IEEE 1284 cable to a PCL3 or PCL5

compatible printer

VGA output 15-pin mini D-Sub female¹

Probe power (nominal) +15 Vdc, -12.6 Vdc at 150 mA max. 10 MHz Ref out 50 Ω nominal BNC (f), >0 dBm 10 MHz Ref in 50 Ω nominal BNC (f), -15 to +10 dBm

BNC Noise source drive output

Connector type 50 Ω -type BNC (f)

Output voltage On: $28.0 \text{ V} \pm 0.1 \text{ V}$ at up to 60mA peak

Off: <1 V

SNS Noise source connector For use with Agilent Technologies'

SNS Series noise sources

^{1. 31.5} kHz horizontal, 60 Hz vertical sync rates, non-interlaced, analog RGB 640 x 480

General specifications

Data storage (nominal)

Internal drive 30 traces, states or ENR tables Floppy disk 30 traces, states or ENR tables

Power requirements

On (line 1) 90 to 132 V rms, 47 to 440 Hz

195 to 250 V rms, 47 to 66 Hz Power consumption<300 W

Standby (line 0) <5 W

Dimensions

Without handle $222mm(H) \times 410mm(D) \times 375mm(W)$ With handle (max) $222mm(H) \times 515mm(D) \times 409mm(W)$

Weight (typical, without options)

 N8972A
 15.3 kg (33.7 lbs.)

 N8973A
 15.5 kg (34.2 lbs.)

 N8974A
 17.5 kg (38.61 lbs.)

 N8975A
 17.5 kg (38.61 lbs.)

Audible noise

<42 dBa pressure and <5.0 bels power (ISODP7779)

Temperature range

Operating 0° C to +55° C Storage -40° C to +70° C

Humidity range

Operating Up to 95% relative humidity to 40° C

(non-condensing)

Altitude range

Operating to 4,600 meters

Calibration interval

1-year minimum recommended

Electromagnetic Compatibility

This product conforms with the protection requirements of European Council Directive 89/336/EEC for Electromagnetic Compatibility (EMC).

The conformity assessment requirements have been met using the technical Construction file route to compliance, using EMC test specifications EN 55011:1991 (Group 1, Class A) and EN 50082-1:1992.

In order to preserve the EMC performance of the product, any cable which becomes worn or damaged must be replaced with the same type and specification.

Radio-Frequency Electromagnetic Field Immunity

When a 3 Vm-1 radio-frequency electromagnetic field is applied to the noise figure analyzer according to IEC 61000-4-3:1995, degradation of performance may be observed. When the frequency of the incident filed matches the frequency of a measured noise figure or gain, the values displayed will deviate from those expected. This phenomenon will only affect that specific frequency, and the analyzer will continue to perform to specification at all other frequency sample points.

The noise figure analyzer may be unable to calibrate a chosen frequency sample point, if the frequency matches that of an incident electromagnetic field. ¹

^{1.} Radiated Immunity Testing. When tested at 3 V/m, according to IEC 801-3/1984, the displayed average noise level will be within specifications over the full immunity test frequency range of 27 MHz to 500 MHz except at the immunity test frequencies of 223.5714 MHz +/- selected resolution bandwidth, and 437.1429 MHz +/- selected resolution bandwidth, where the displayed average noise level can be up to -45 dBm. When the noise figure analyzer tuned frequency is identical to these immunity test frequencies, the measurements could be corrupted and there may be signals of up to -70 dBm displayed on the screen.

For further information

Key literature:

Please visit the Agilent noise figure analysis web site for on-line access to literature or contact your local Agilent sales office or representative.

Noise Figure Analyzers - NFA Series - Brochure, literature number 5980-0166E

Noise Figure Analyzers - NFA Series - Configuration Guide, literature number $5980\text{-}0163\mathrm{E}$

Fundamentals of RF and Microwave Noise Figure Measurements, Application Note 57-1, literature number 5952-8255E

Noise Figure Measurement Accuracy, Application Note 57-2, literature number 5952-3706E

10 Hints for Making Successful Noise Figure Measurements; Application Note 57-3, literature number 5980-0288E

Key web resources:

For the latest information on our noise figure solutions, see our web page at:

www.agilent.com/find/nf

For the latest news on the component test industry, see our web page at:

www.agilent.com/find/component test

For the latest news in the aerospace industry, see our web page at:

www.agilent.com/find/aerospace

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